



Pb



20V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)} max	I _D Max T _A = 25°C (Notes 3 & 5)
Q1	20V	$20m\Omega @ V_{GS} = 4.5V$	8.5A
QT		$28m\Omega @ V_{GS} = 2.5V$	7.2A
02	-20V	$33m\Omega @ V_{GS} = -4.5V$	-6.8A
Q2		$45m\Omega @ V_{GS} = -2.5V$	-5.8A

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

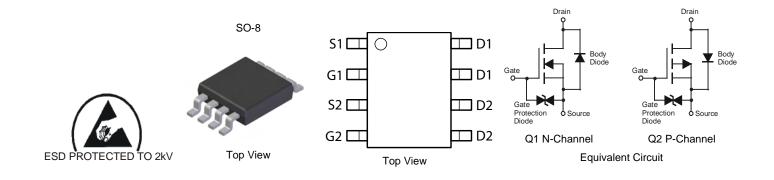
- Motor control
- DC-DC Converters
- Power management functions
- Notebook Computers and Printers

Features and Benefits

- Reduced footprint with two discretes in a single SO8
- Low gate drive
- Low input capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected up to 2kV
- "Lead Free", RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 1)

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame. Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)



Ordering Information (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMC2020USD-13	C2020UD	13	12	2,500

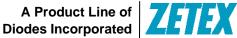
Notes: 1. No purposefully added lead. Diodes Inc.'s "Green" policy and packaging details can be found on our website at http://www.diodes.com.

Marking Information



Cli = Manufacturer's Marking C2020UD = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01 - 53)





Maximum Ratings @T_A = 25°C unless otherwise specified

	Symbol	N-Channel - Q1	P-Channel - Q2	Units			
Drain-Source Voltage			V _{DSS}	20	-20	V	
Gate-Source Voltage			V _{GSS}	±10	±10	V	
Continuous Drain Current	V _{GS} = 4.5V	(Notes 3 & 5)	I _D	8.5	-6.8	A	
		T _A = 70°C (Notes 3 & 5)		6.8	-5.4		
Continuous Drain Current		(Notes 2 & 5)		6.5	-5.2		
		(Notes 2 & 6)		7.8	-6.3		
Pulsed Drain Current V _{GS} = 4.5V		(Notes 4 & 5)	I _{DM}	33.6	-26.8	l	
Continuous Source Current (Body diode)		(Notes 3 & 5)	Is	4.0	-4.0	1	
Pulsed Source Current (Body diode) (N		(Notes 4 & 5)	I _{SM}	33.6	-26.8		

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic	Symbol	N-Channel - Q1	P-Channel - Q2	Unit		
	(Notes 2 & 5)		1.2	W mW/°C		
Power Dissipation Linear Derating Factor	(Notes 2 & 6)	PD	1.8 14.3 2.14 17.2			
	(Notes 3 & 5)					
	(Notes 2 & 5)		10	0	2004	
Thermal Resistance, Junction to Ambient	(Notes 2 & 6)	R _{0JA}	70)		
	(Notes 3 & 5)		58	3	°C/W	
Thermal Resistance, Junction to Lead	(Notes 5 & 7)	R _{0JL}	51			
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to	+150	°C		

2. For a device surface mounted on 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is Notes:

measured when operating in a steady-state condition.

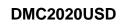
3. Same as note (2), except the device is measured at $t \le 10$ sec. 4. Same as note (2), except the device is pulsed with D = 0.02 and pulse width 300µs.

5. For a dual device with one active die.

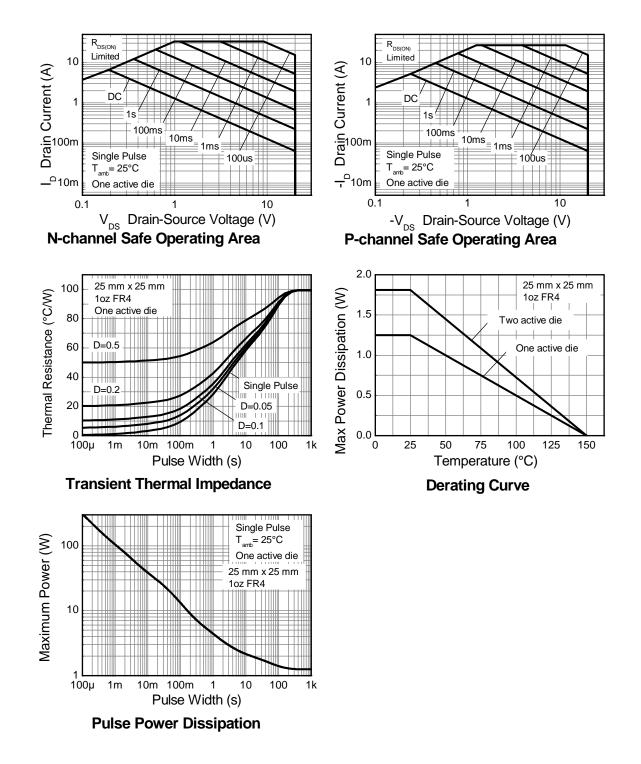
6. For a device with two active die running at equal power.

7. Thermal resistance from junction to solder-point (at the end of the drain lead).





Thermal Characteristics





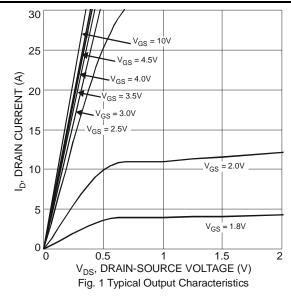


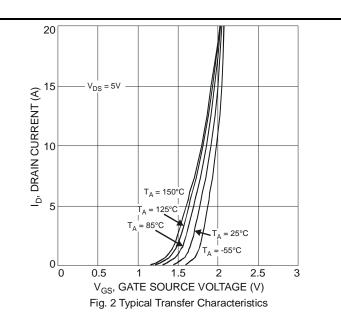
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS						•		
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V, I_D = 250 \mu A$		
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1.0	μA	$V_{DS} = 20V, V_{GS} = 0V$		
Gate-Source Leakage	IGSS	-	-	±10	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$		
ON CHARACTERISTICS	•							
Gate Threshold Voltage	V _{GS(th)}	0.5	1.1	1.5	V	$V_{DS} = V_{GS}, I_D =$	= 250µA	
Static Drain-Source On-Resistance (Note 8)	P		13	20	mΩ	V_{GS} = 4.5V, I_D	= 7A	
	R _{DS (ON)}	-	18	28	11122	$V_{GS} = 2.5V, I_D = 3A$		
Forward Transfer Admittance (Notes 8 & 9)	Y _{fs}	-	16	-	S	$V_{DS} = 5V, I_{D} = 9.4A$		
Diode Forward Voltage (Note 8)	V _{SD}	-	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1.3A$		
Continuous Source Current	ls	-	-	1.8	А	-		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	Ciss	-	1149	-		$V_{DS} = 10V, V_{GS} = 0V,$ f = 1.0MHz		
Output Capacitance	C _{oss}	-	157	-	pF			
Reverse Transfer Capacitance	C _{rss}	-	142	-		1 = 1.00012		
Gate Resistance	Rg	-	1.51	-	Ω	$V_{DS} = 0V, V_{GS}$	= 0V, f = 1MHz	
Total Gate Charge (Note 10)	Qg	-	6.0	-		$V_{GS} = 2.5V$		
Total Gate Charge (Note 10)	Qg	-	11.6	-				
Gate-Source Charge (Note 10)	Q _{gs}	-	2.7	-	nC		$V_{DS} = 10V$	
Gate-Drain Charge (Note 10)	Q _{gd}	-	3.4	-		$V_{GS} = 4.5V$	$I_D = 9.4A$	
Turn-On Delay Time (Note 10)	t _{D(on)}	-	11.67	-				
Turn-On Rise Time (Note 10)	tr	-	12.49	-		$V_{GS} = 4.5V, V_{DS} = 10V,$		
Turn-Off Delay Time (Note 10)	t _{D(off)}	-	35.89	-	ns			
Turn-Off Fall Time (Note 10)	t _f	-	12.33	-	1	$R_G = 6\Omega$, $I_D = 1A$		

8. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$ Notes: 9. For design aid only, not subject to production testing.

10. Switching characteristics are independent of operating junction temperatures.

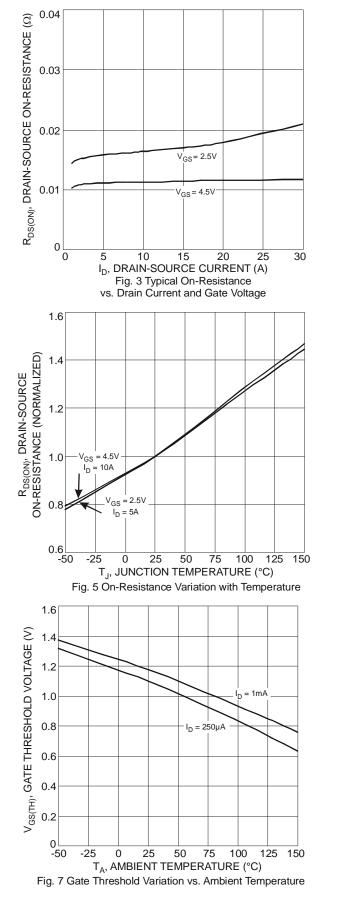
Typical Characteristics – Q1 N-CHANNEL

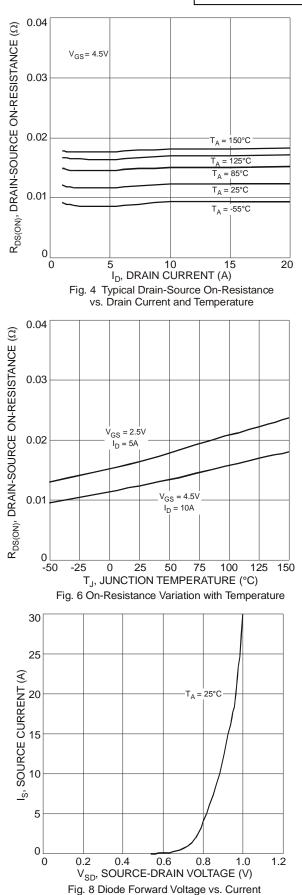






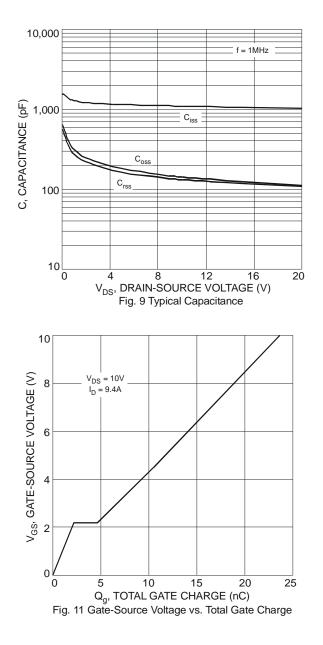


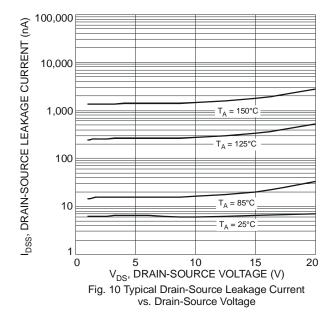














Notes:

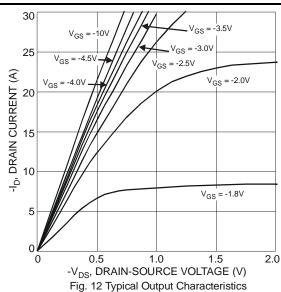


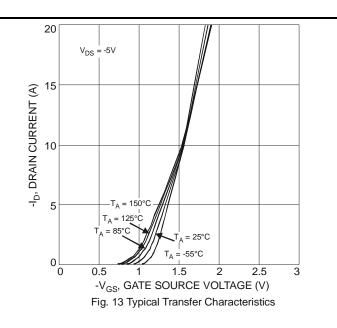
DMC2020USD

Characteristic	Symbol	Min	Тур	Max	Unit	Test C	ondition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	-	V	$V_{GS} = 0V, I_D =$	-250µA
Zero Gate Voltage Drain Current	IDSS	-	-	-1.0	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 8V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(th)}	-0.4	-0.7	-1.0	V	$V_{DS} = V_{GS}, I_D =$	⊧ -250µA
Static Drain-Source On-Resistance (Note 11)			26	33	mΩ	$V_{GS} = -4.5V, I_{D}$	= -6A
	R _{DS} (ON)	-	33	45	11122	$V_{GS} = -2.5V, I_D = -3A$	
Forward Transfer Admittance (Note 11 & 12)	Y _{fs}	-	14	-	s	$V_{DS} = -5V, I_{D} = -4A$	
Diode Forward Voltage (Note 11)	V _{SD}	-	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
Continuous Source Current	Is	-	-	-1.8	А	-	
DYNAMIC CHARACTERISTICS (Note 12)						•	
Input Capacitance	C _{iss}	-	1610	-			
Output Capacitance	Coss	-	157	-	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	-	145	-		1 = 1.00012	
Gate Resistance	R _g	-	9.45	-	Ω	$V_{DS} = 0V, V_{GS}$	= 0V, f = 1MH
Total Gate Charge (Note 13)	Qg	-	8.0	-		$V_{GS} = -2.5V$	
Total Gate Charge (Note 13)	Qg	-	15.4	-	nC		$V_{DS} = -10V$
Gate-Source Charge (Note 13)	Q _{qs}	-	2.5	-	nc	$V_{GS} = -4.5V$	$I_D = -4A$
Gate-Drain Charge (Note 13)	Q _{qd}	-	3.3	-			
Turn-On Delay Time (Note 13)	t _{D(on)}	-	16.8	-		V _{GS} = -4.5V, V _{DS} = -10V,	
Turn-On Rise Time (Note 13)	tr	-	12.4	-			
Turn-Off Delay Time (Note 13)	t _{D(off)}	-	94.1	-	ns	$R_G = 6\Omega$, $I_D = -$	-1A
Turn-Off Fall Time (Note 13)	t _f	-	42.4	-			

11. Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2% 12. For design aid only, not subject to production testing. 13. Switching characteristics are independent of operating junction temperatures.

Typical Characteristics – Q2 P-CHANNEL



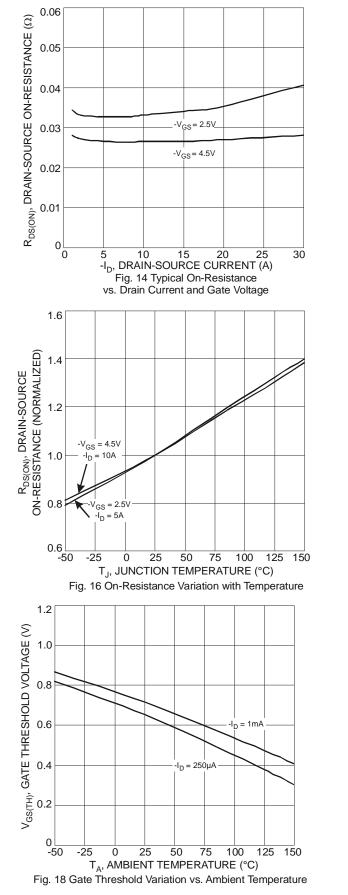


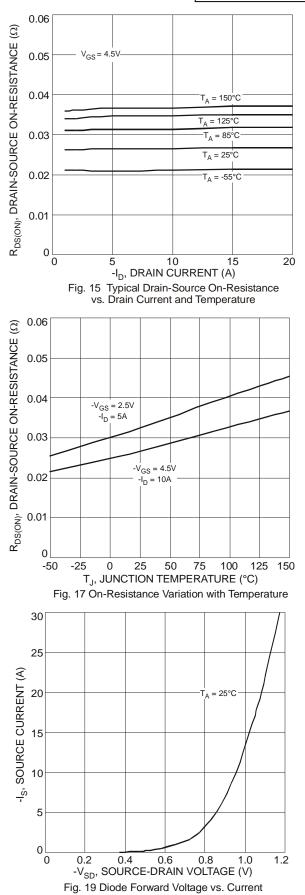


A Product Line of Diodes Incorporated



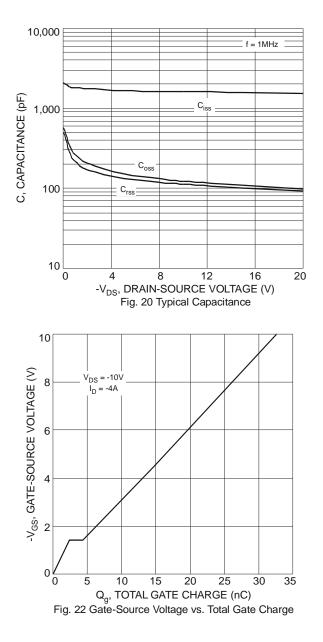


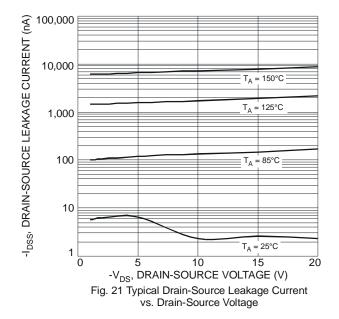








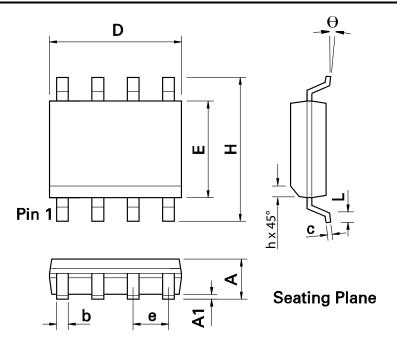






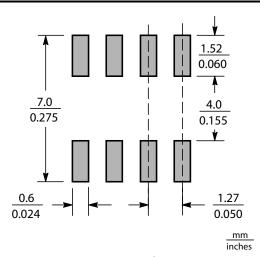


Package Outline Dimensions



DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
А	0.053	0.069	1.35	1.75	e	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Suggested Pad Layout





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